

HIGH VOLTAGE SEMINAR

BING LU

ISOLATED GATE DRIVERS

INTRODUCTION TO EMI IN POWER SUPPLY DESIGNS

Outline

- Introduction to EMI and EMC
- EMI standard and measurement method
- Differential and common mode EMI noise source, path, and spectrume
- EMI filter and design considerations
- Other EMI mitigation method

EMI and EMC

- Electromagnetic Interference
- The equipment should not interfere with other systems
 - For example: turning on AC/DC power supply should not interfere with radio operation

- Electromagnetic Compatibility
- The equipment should operate normally even with interference from the noise
 - For example: the AC/DC power supply should operate normally in noisy environment with heavy machinery

EMI challenges in power supply design

- EMI is a challenge for nearly all electronic systems
- EMI source → coupling path → receptor
 - Conducted path through cabling
 - Radiated EMI path through air
- Conducted EMI: EN55022 covers frequencies from 150kHz to 30MHz
- Radiated EMI: EN55022 covers frequencies from 30 MHz to 1 GHz
- Leverage IC and system-level features:
 - Careful PCB layout
 - Spread spectrum / slew-rate control
 - EMI filtering

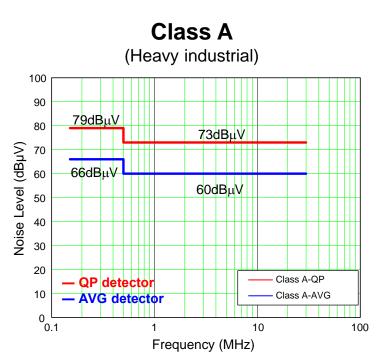


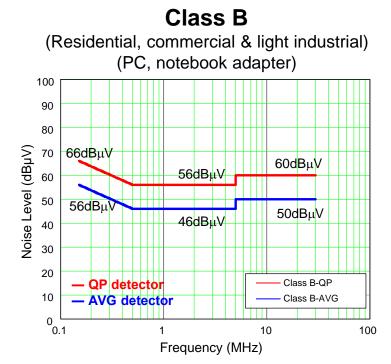
PMP21251

Less than 90 mW Ultra-low standby power auxless AC-DC power supply

EN55022 limit lines: conducted emissions

Class A and Class B limits, quasi-peak & average, 15 0kHz-30 MHz



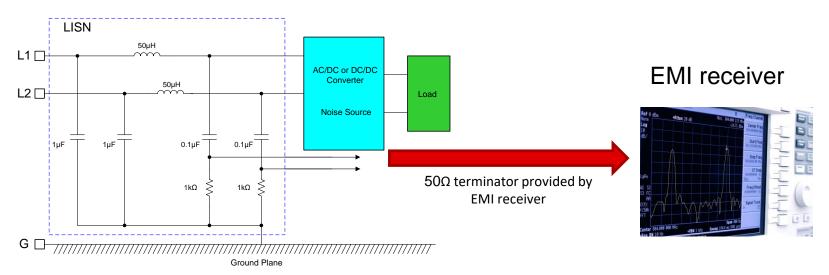


EN55022, "Information technology equipment— Radio disturbance characteristics— Limits and methods of measurement"

Line impedance stabilization network (LISN)

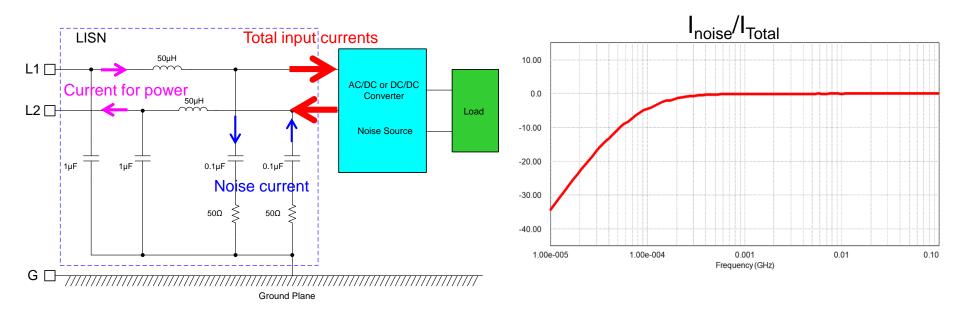
- 1. Stable line source impedance
- 2. Isolation of power source noise
- 3. Safe connection of measuring equipment

- 4. "Total" noise levels measured separately in L1 and L2
- 5. Terminated into 50Ω , internal to EMI receiver



^{**} Functional equivalent circuit of a LISN, not a complete schematic **

LISN properties



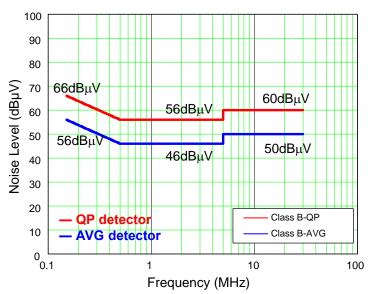
- LISN is a high-pass filter
- High frequency current (noise) is trapped by the LISN capacitor and the amplitude is measured based on the voltage across 50Ω load



EMI noise and current amplitude

QUESTION:

The EN55022 Class B QP conducted emission limit is 60dBµV at 10MHz What is the current level at the conducted emission limit in: (a) μ A, (b) dB μ A



ANSWER:

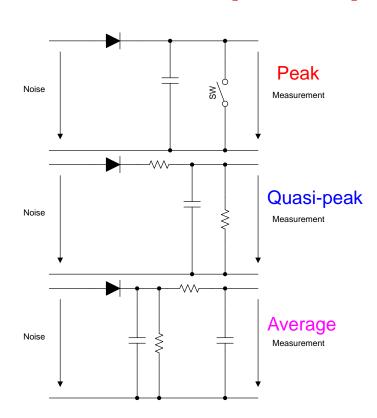
$$V_{noise} = 60dB\mu V = 10^{\frac{60}{20}} \times \mu V = 1mV$$

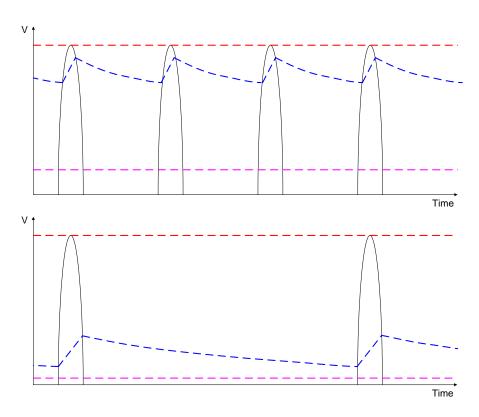
$$I_{noise} = \frac{1mV}{50\Omega} = 20\mu A$$

$$I_{noise} = 20\mu A = 20 \log(20) dB\mu A = 26.02 dB\mu A$$

EMI noise current has very low amplitude

EMI detector, peak, quasi-peak, average



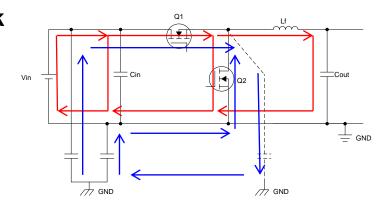


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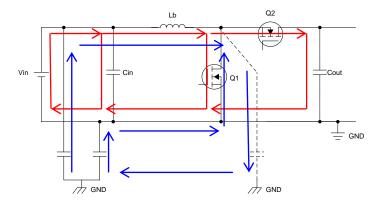
DM and CM conducted noise paths: buck & boost

- 1. Differential-mode (DM) noise current flows in power lines with opposite directions
- 2. Common-mode (CM) noise current flows in power lines with same direction

Buck



Boost



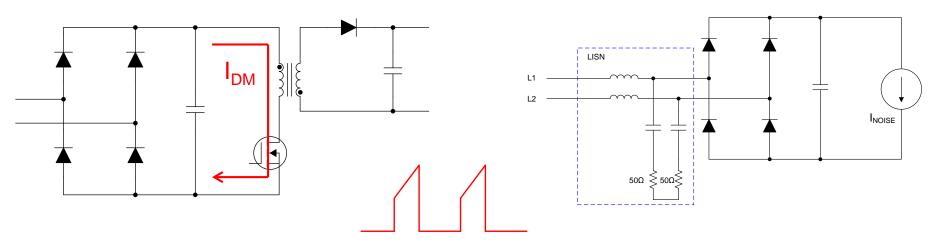
DM noise behavior

"Current driven", di/dt, magnetic field, low impedance

CM noise behavior

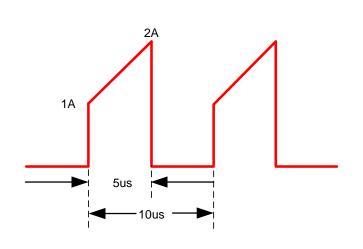
"Voltage driven", dv/dt, electric field, high impedance

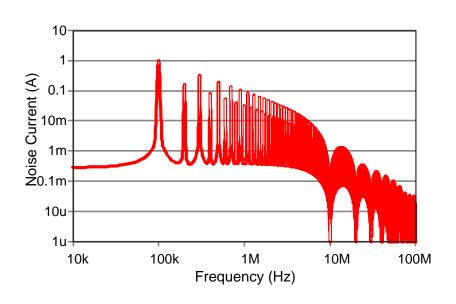
DM noise equivalent circuit



- The differential mode current is essentially the current used to deliver power to the system (input current)
- It's normally a trapezoidal or triangular shape for switch mode power supplies

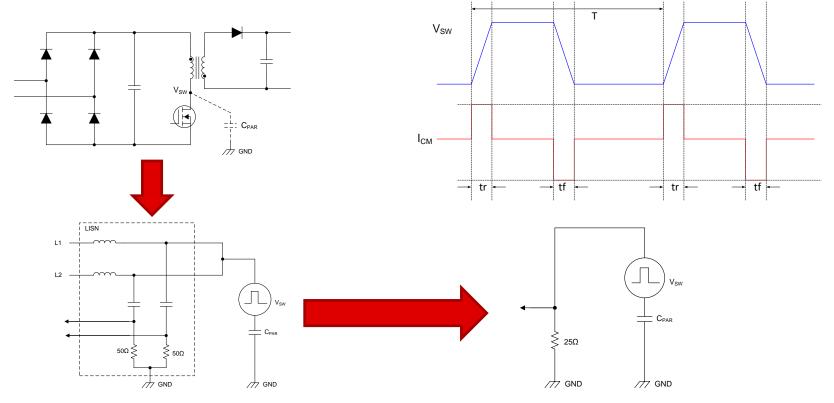
DM noise spectrum





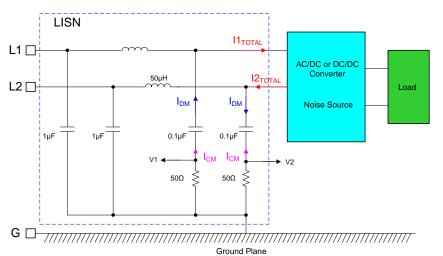
- The trapezoidal current shape gives roughly a -20dB/dec slope
- The DM noise can be easily estimated based on power stage operation waveforms

Equivalent circuit for CM noise

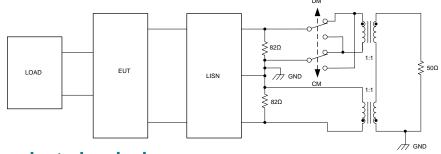


CM noise current spectrum Envelope (dB) -20dB/dec Zc_{PAR} -20dB/dec -40dB/dec 25Ω /// GND // GND I_{NOISE} envelope (dB) 0dB/dec -20dB/dec $\overline{\pi t_r}$ Common mode noise appears as a flat envelope πt_r What can I do to improve CM EMI?

Measure conducted emissions (DM & CM) with LISN



$$\left|\frac{V_1 + V_2}{2}\right| = 50\Omega \times |I_{CM}| \quad \left|\frac{V_2 - V_1}{2}\right| = 50\Omega \times |I_{DM}|$$



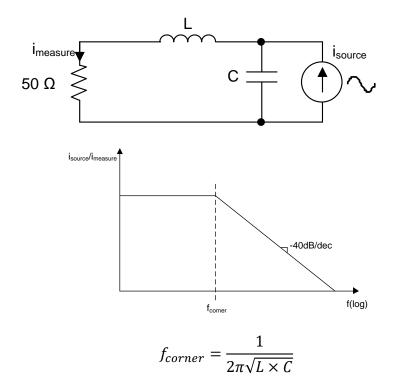
Separation of DM/CM conducted emissions:

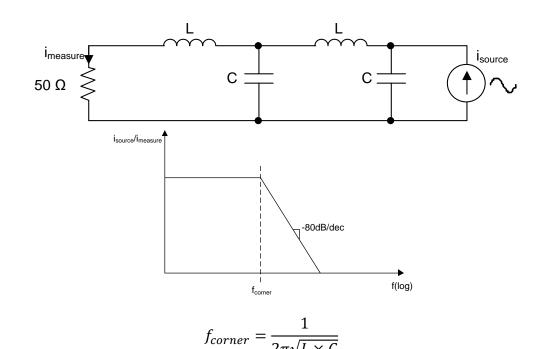
- Diagnosis of power supply conducted EMI
 - Troubleshoot source of emissions

- 2. EMI filter design
 - Directly measure the required DM & CM attenuation
 - Minimize filter component count & size for optimized design

Characterization, evaluation, and design of noise separator for conducted EMI noise diagnosis, Shuo Wang; F.C. Lee; W.G. Odendaal, IEEE Transactions on Power Electronics, Year: 2005, Volume: 20, Issue: 4, Pages: 974 - 982

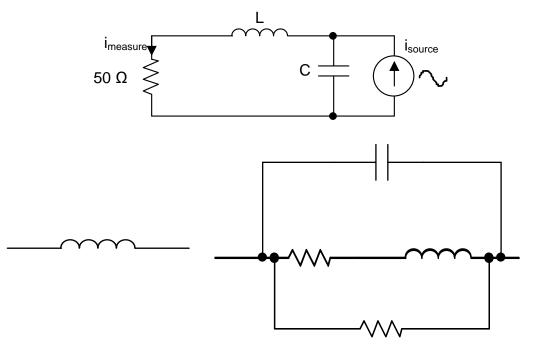
Filter attenuation





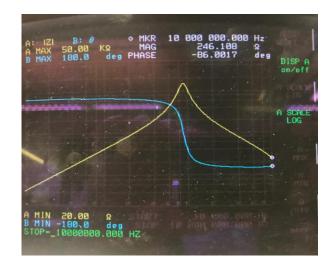
What if the two stages are not the same?

Equivalent circuit for inductor

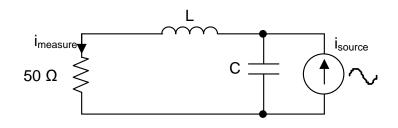


Inductor might not be an inductor at certain frequency

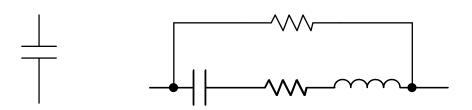




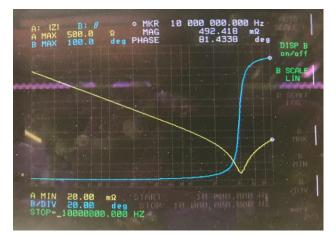
Equivalent circuit for capacitor



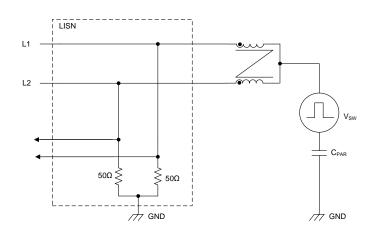


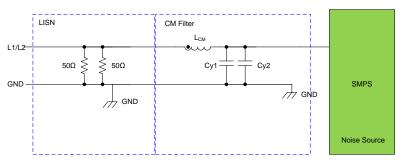


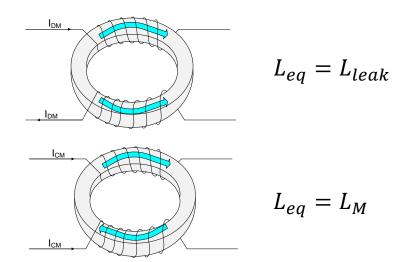
Capacitor might not be a capacitor at certain frequency



CM filter



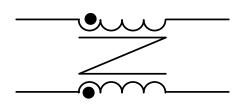


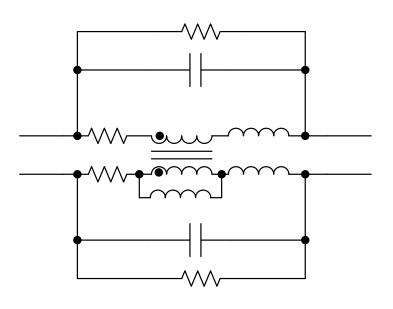


- CM inductor has large inductance for common mode current, while very little inductance for differential mode current
- CM capacitor (Y-cap) often used to provide high frequency path for the common mode current and provides more attenuation

Common mode inductor equivalent circuit







CM inductor constructions





- Properties
 - Less differential impedance
 - High capacitive coupling
 - Less leakage inductance
- Application
 - Data lines
 - Sensor lines
 - USB, HDMI



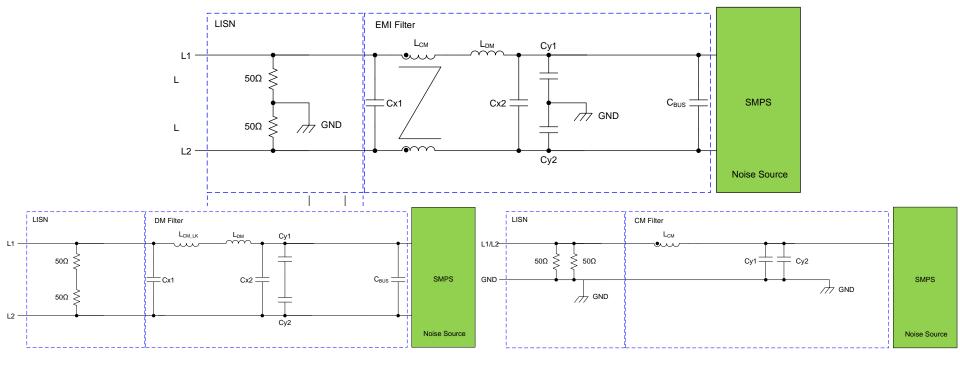


Sectional

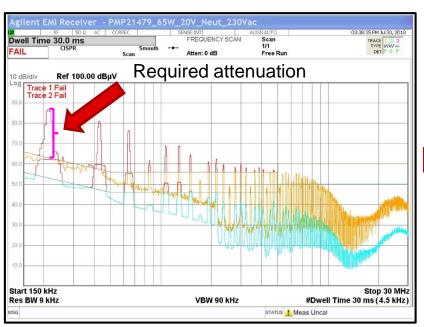
- Properties
 - Low capacitive coupling
 - High leakage inductance
- Applications
 - Power supply input/output filter
 - Switching power supply decoupling

EMI filter, DM & CM equivalent circuits

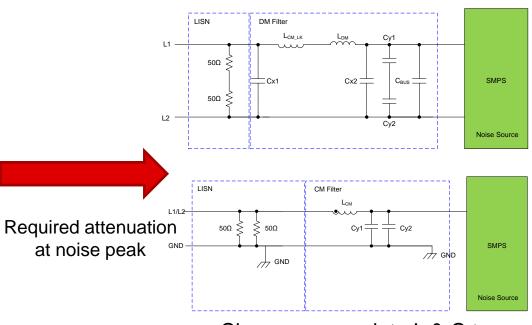
Standard π -filter



Design EMI filter flow chart



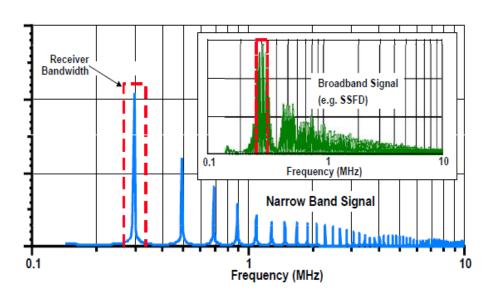
Measure raw noise



Choose appropriate L & C to provide attenuation at the frequency

Spread spectrum/dithering: what is it?

Spread spectrum is a technique to reduce EMI by dithering the switching frequency



Spread spectrum reduces the overall peak value while widening the spectrum

Summary

- EMI noise is created/associated with the switching mode power supply operation
- The EMI noise is measured through LISN
 - The noise current needs to be very low amplitude
- The EMI noise can be separated into DM and CM noise
 - DM noise is part of the power delivery
 - CM noise is coupled through the parasitic capacitor, caused by high dv/dt
- The EMI noise is often mitigated by EMI filtering
 - Differential mode filter
 - Common mode filter
- By measuring the raw EMI noise, the EMI filter can be designed to provide the required noise attenuation



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